

Search Notes

Application/Control No.

10/712,356

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

JUNG ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	20,40,44 47,50,54 56,65	6/22/2006	SWH
216	27	6/22/2006	SWH
430	320	6/22/2006	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR